June 2004

FDC6000NZ

Dual N-Channel 2.5V Specified PowerTrench® MOSFET

General Description

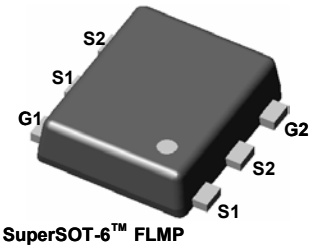
This N-Channel 2.5V specified MOSFET is a rugged gate version of Fairchild's Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (2.5V – 12V). Packaged in FLMP SSOT-6, the $R_{DS(ON)}$ and thermal properties of the device are optimized for battery power management applications.

Applications

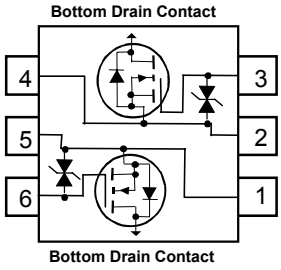
- Battery management/Charger Application
- Load switch

Features

- 6.5 A, 20 V $R_{DS(ON)}$ = 20 mΩ @ V_{GS} = 4.5 V
  $R_{DS(ON)}$ = 28 mΩ @ V_{GS} = 2.5 V
- ESD protection diode (note 3)
- High performance trench technology for extremely low $R_{DS(ON)}$
- FLMP SSOT-6 package: Enhanced thermal performance in industry-standard package size



SuperSOT-6™ FLMP



MOSFET Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DSS}	Drain-Source Voltage		20	V
V_{GSS}	Gate-Source Voltage		±12	V
I_D	Drain Current – Continuous	(Note 1a)	7.3	A
	– Pulsed		20	
P_D	Power Dissipation for Dual Operation	(Note 1a)	1.6	W
	Power Dissipation for Single Operation	(Note 1a)	1.8	
		(Note 1b)	1.2	
T_J, T_{STG}	Operating and Storage Junction Temperature Range		–55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	68	°C/W
$R_{\theta Jc}$	Thermal Resistance, Junction-to-Case	(Note 1a)	1	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
.0NZ	FDC6000NZ	7''	8mm	3000 units

Electrical Characteristics

T_A = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain–Source Breakdown Voltage	V_{GS} = 0 V, I_D = 250 μA	20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C		14		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 16 V, V_{GS} = 0 V			1	μA
I_{GSS}	Gate–Body Leakage	V_{GS} = ±12 V, V_{DS} = 0 V			± 10	μA
On Characteristics (Note 2)						
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250 μA	0.6	0.9	1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C		–4		mV/°C
$R_{DS(on)}$	Static Drain–Source On–Resistance	V_{GS} = 4.5 V, I_D = 6.5 A V_{GS} = 4.0 V, I_D = 6.4 A V_{GS} = 3.1 V, I_D = 6.3 A V_{GS} = 2.5 V, I_D = 5.5 A V_{GS} = 4.5 V, I_D = 6.5A, T_J=125°C		16.5 16.8 19.2 22.5 22.8	20 21 24 28 30	mΩ
g_{FS}	Forward Transconductance	V_{DS} = 5 V, I_D = 6.5 A		30		S
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 10 V, V_{GS} = 0 V, f = 1.0 MHz		840		pF
C_{oss}	Output Capacitance			210		pF
C_{rss}	Reverse Transfer Capacitance			100		pF
R_G	Gate Resistance	V_{GS} = 15 mV, f = 1.0 MHz		2.3		Ω
Switching Characteristics (Note 2)						
$t_{d(on)}$	Turn–On Delay Time	V_{DD} = 10 V, I_D = 1 A, V_{GS} = 4.5 V, R_{GEN} = 6 Ω		10	20	ns
t_r	Turn–On Rise Time			15	27	ns
$t_{d(off)}$	Turn–Off Delay Time			18	32	ns
t_f	Turn–Off Fall Time			9	18	ns
Q_g	Total Gate Charge	V_{DS} = 10 V, I_D = 6.5 A, V_{GS} = 4.5 V		8	11	nC
Q_{gs}	Gate–Source Charge			1.5		nC
Q_{gd}	Gate–Drain Charge			2.1		nC
Drain–Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain–Source Diode Forward Current				1.25	A
V_{SD}	Drain–Source Diode Forward Voltage	V_{GS} = 0 V, I_S = 1.25A (Note 2)		0.7	1.2	V

Electrical Characteristics

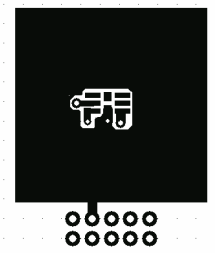
T_A = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Drain–Source Diode Characteristics and Maximum Ratings						
t_{rr}	Diode Reverse Recovery Time	I_F = 6.5 A, d_{iF}/d_t = 100 A/µs		16		nS
Q_{rr}	Diode Reverse Recovery Charge			4.3		nC

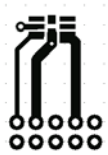
NOTES:

1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the

drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 68°C/W when mounted on a 1in^2 pad of 2 oz copper (Single Operation).



b) 102°C/W when mounted on a minimum pad of 2 oz copper (Single Operation).

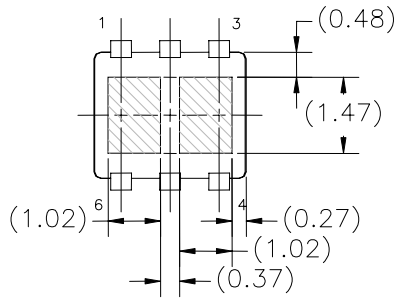
Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

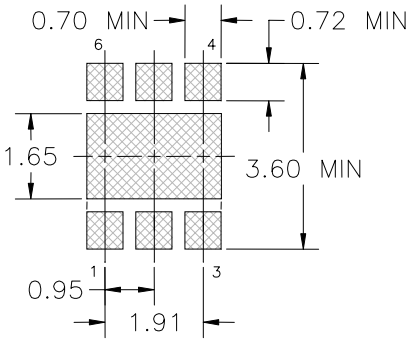
3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

4. Electrical characterization and datasheet limits was based on a single source configuration (pin 2 & 5 no connection).

Dimensional Outline and Pad Layout

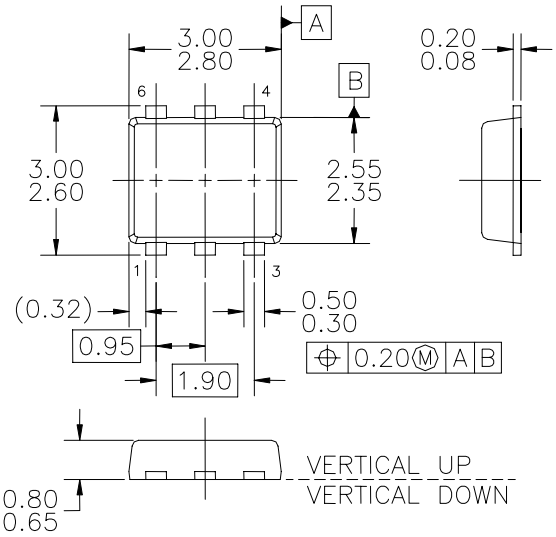


Bottom View

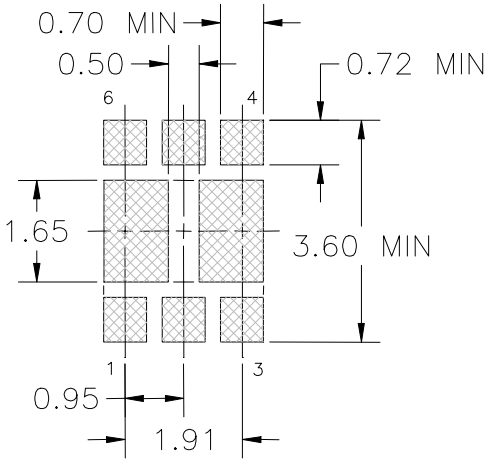


Recommended Landing Pattern

For Common Drain Configuration



Top View



Recommended Landing Pattern

For Standard Dual Configuration

NOTES: UNLESS OTHERWISE SPECIFIED

ALL DIMENSIONS ARE IN MILLIMETERS.

Typical Characteristics

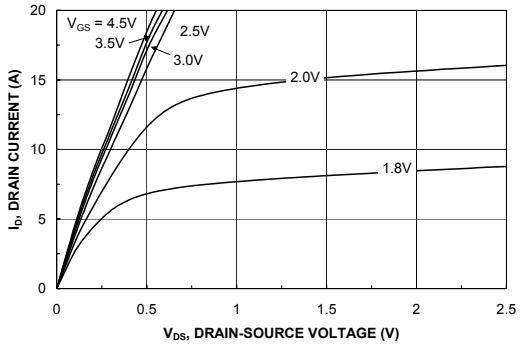


Figure 1. On-Region Characteristics.

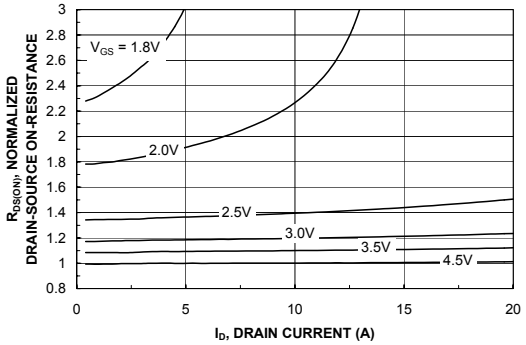


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

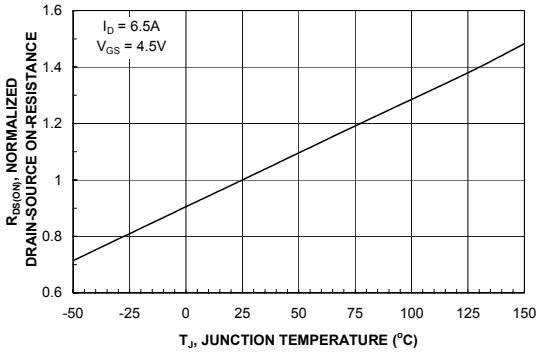


Figure 3. On-Resistance Variation with Temperature.

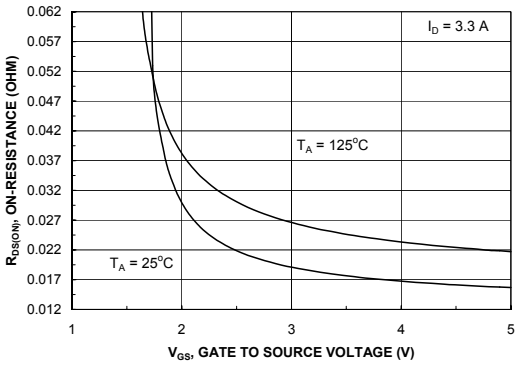


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

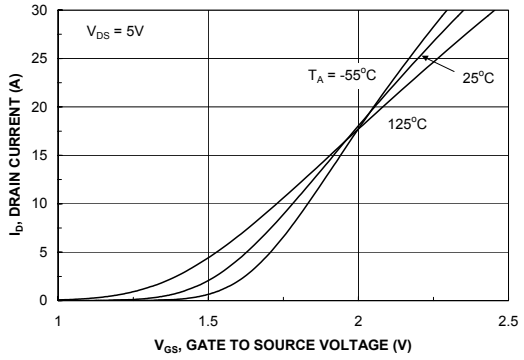


Figure 5. Transfer Characteristics.

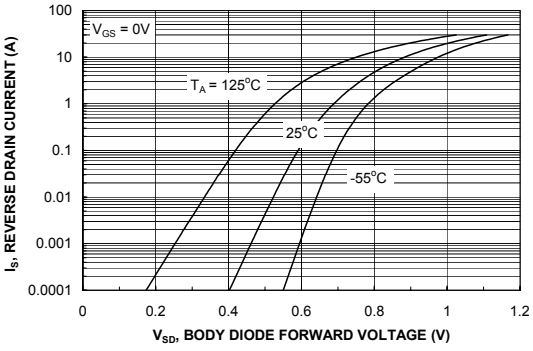


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics

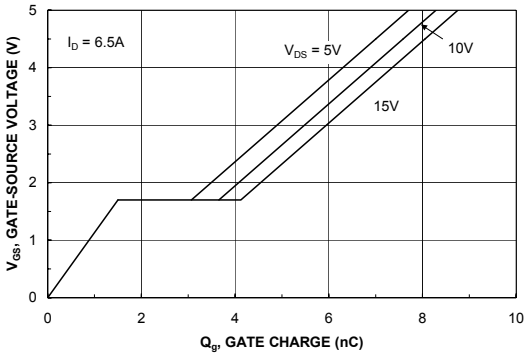


Figure 7. Gate Charge Characteristics.

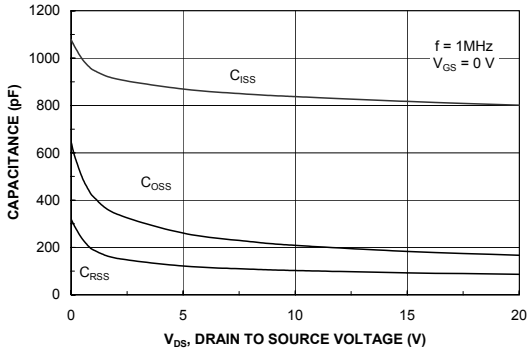


Figure 8. Capacitance Characteristics.

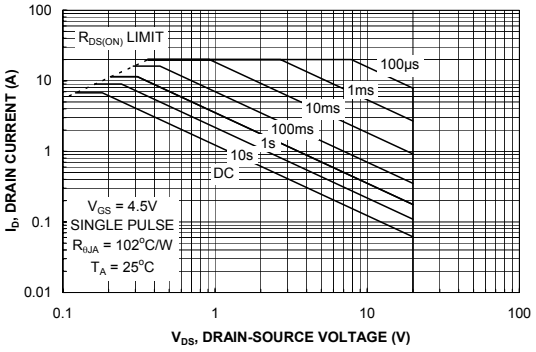


Figure 9. Maximum Safe Operating Area.

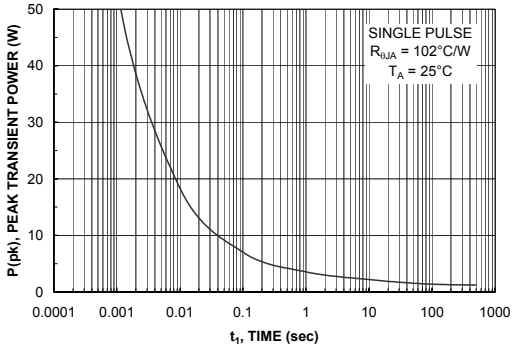


Figure 10. Single Pulse Maximum Power Dissipation.

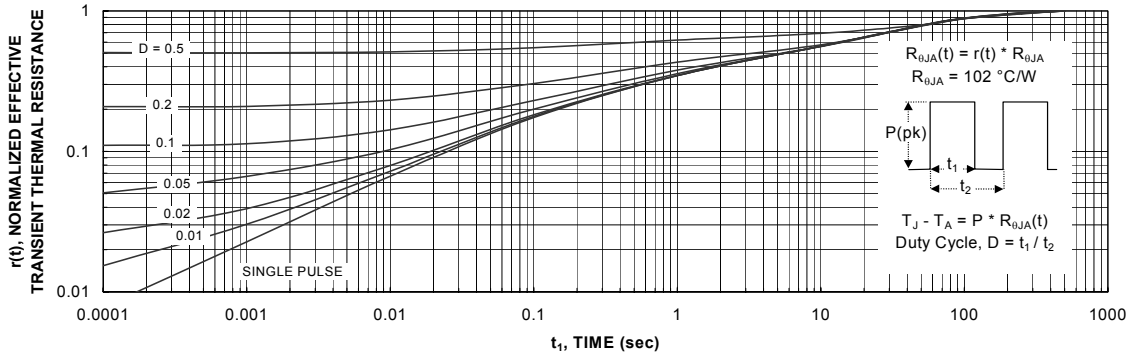


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b.
Transient thermal response will change depending on the circuit board design.

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E^2CMOS™	I^2C™	MSXPro™	RapidConfigure™	TruTranslation™
EnSigna™	*i-Lo*™	OCX™	RapidConnect™	UHC™
FACT™	ImpliedDisconnect™	OCXPro™	µSerDes™	UltraFET®
FACT Quiet Series™		OPTOLOGIC®	SILENT SWITCHER®	VCX™
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Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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